

**Search Notes**

Application/Control No.

10/762,246

Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

HANINA ET AL.

Art Unit

2861

**SEARCHED**

Class	Subclass	Date	Examiner
347	233, 238, 241-245, 256-261	9/22/2006	HP
	231		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
347	233, 243	9/22/2006	HP
	260		
PGPub text Search		9/22/2006	HP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	9/22/2006	HP